

ABSTRACT OF THE DISCLOSURE

A test apparatus for testing an electronic device, includes a test module for sending and/or receiving a test signal to and/or from the electronic device, a test head including a plurality of TH slots for detachably holding the test module, a diagnosis module for performing diagnosis of the test module, and coupling means including a plurality of PB slots being electrically coupled to the TH slots respectively for detachably holding the diagnosis module. The diagnosis module held in one of the PB slots diagnoses the test module held in one of the TH slots being electrically coupled to the one the PB slots.